







PCA9546A ZHCSNJ3I - OCTOBER 2005 - REVISED JUNE 2022

具有复位功能的 PCA9546A 低压 4 通道 I2C 和 SMbus 开关

1 特性

- 4 选 1 双向转换开关
- 与 I²C 总线和 SMBus 兼容
- 低电平有效复位输入
- 三个地址引脚,允许在 I2C 总线上使用多达八个 PCA9546A 器件
- 以任意组合通过 I²C 总线实现通道选择
- 加电时所有开关通道取消选定
- 低 R_{ON} 开关
- 支持 1.8V、2.5V、3.3V 和 5V 总线间的电压电平转
- 加电时无干扰
- 支持热插入
- 低待机电流
- 工作电源电压范围为 2.3V 至 5.5V
- 5.5V 耐压输入
- 0至 400kHz 时钟频率
- 锁断性能超过了 100mA,符合 JESD 78 规范
- ESD 保护性能超过 JESD 22 规范要求
 - 2000V 人体放电模型 (A114-A)
 - 1000V 带电器件模型 (C101)

2 应用

- 服务器
- 路由器(电信交换设备)
- 工厂自动化
- 具有 I²C 从地址冲突的产品 (例如,多个完全一样 的温度传感器)

3 说明

PCA9546A 是一款由 I²C 总线控制的四路双向转换开 关。SCL/SDA 上行对扩展到四个下行对,或者通道。 根据可编程控制寄存器的内容,可选择任一单独 SCn/SDn 通道或者通道组合。

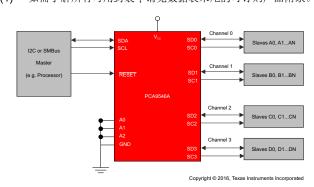
一个低电平有效 (RESET) 输入使得 PCA9546A 能够 在其中一个下行 I2C 总线长时间处于低电平状态时恢 复。将 RESET 下拉为低电平会使 I²C 状态机复位,并 且使所有通道取消选中,这一功能与内部上电复位功能 的作用一样。

由于开关上有导通栅极,因此 V_{CC} 引脚可用于限制将 由 PCA9546A 传递的最大电压。这允许在每个对上使 用不同的总线电压,以便 1.8V, 2.5V 或 3.3V 部件可 以在没有任何额外保护的情况下与 5V 部件通信。对于 每个通道,外部上拉电阻器将总线电压上拉至所需的电 压电平。所有 I/O 引脚为 5.5V 耐压。

封装信息

| | NAHO | |
|----------|-------------------|-----------------|
| 器件型号 | 封装 ⁽¹⁾ | 封装尺寸 (标称值) |
| | SOIC (D) (16) | 9.90mm x 3.91mm |
| | TVSOP (DGV) (16) | 3.60mm x 4.40mm |
| PCA9546A | SOIC (DW) (16) | 10.3mm x 7.50mm |
| CA3540A | TSSOP (PW) (16) | 5.00mm x 4.40mm |
| | VQFN (RGV) 16 | 4.00mm x 4.00mm |
| | VQFN (RGY) (16) | 4.50mm x 3.50mm |

如需了解所有可用封装,请见数据表末尾的可订购产品附录。



简化版应用示意图



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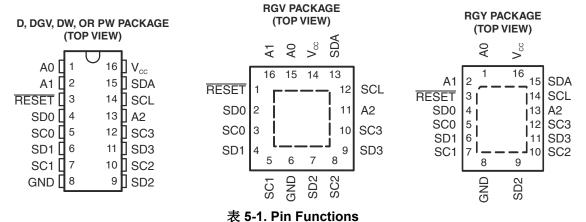
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5 Pin Configuration and Functions



| | PIN | | |
|-----------------|----------------------------|-----|--|
| | NO. | | DESCRIPTION |
| NAME | D, DGV, DW, PW, AND RGY | RGV | |
| A0 | 1 | 15 | Address input 0. Connect directly to V _{CC} or ground |
| A1 | 2 | 16 | Address input 1. Connect directly to V _{CC} or ground |
| A2 | 13 | 11 | Address input 2. Connect directly to V _{CC} or ground |
| GND | 8 | 6 | Ground |
| RESET | 3 | 1 | Active low reset input. Connect to V _{DPUM} ⁽¹⁾ through a pull-up resistor, if not used. |
| SD0 | 4 | 2 | Serial data 0. Connect to V _{DPU0} ⁽¹⁾ through a pull-up resistor |
| SC0 | 5 | 3 | Serial clock 0. Connect to V _{DPU0} ⁽¹⁾ through a pull-up resistor |
| SD1 | 6 | 4 | Serial data 1. Connect to V _{DPU1} ⁽¹⁾ through a pull-up resistor |
| SC1 | 7 | 5 | Serial clock 1. Connect to V _{DPU1} ⁽¹⁾ through a pull-up resistor |
| SD2 | 9 | 7 | Serial data 2. Connect to V _{DPU2} ⁽¹⁾ through a pull-up resistor |
| SC2 | 10 | 8 | Serial clock 2. Connect to V _{DPU2} ⁽¹⁾ through a pull-up resistor |
| SD3 | 11 | 9 | Serial data 3. Connect to V _{DPU3} ⁽¹⁾ through a pull-up resistor. |
| SC3 | 12 | 10 | Serial clock 3. Connect to V _{DPU3} ⁽¹⁾ through a pull-up resistor |
| SCL | 14 | 12 | Serial clock line. Connect to V _{DPUM} ⁽¹⁾ through a pull-up resistor |
| SDA | 15 | 13 | Serial data line. Connect to V _{DPUM} ⁽¹⁾ through a pull-up resistor |
| V _{CC} | 16 | 14 | Supply power |

⁽¹⁾ V_{DPUX} is the pull-up reference voltage for the associated data line. V_{DPUM} is the master I²C reference voltage while V_{DPU0} - V_{DPU3} are the slave channel reference voltages.



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

| | | MIN | MAX | UNIT |
|------------------|--|-------|--------------|------|
| V _{CC} | Supply voltage | - 0.5 | 7 | V |
| VI | Input voltage (2) | - 0.5 | 7 | V |
| I _I | Input current | | ±20 | mA |
| Io | Output current | | ±25 | mA |
| | Continuous current through V _{CC} | | ±100 | mA |
| | Continuous current through GND | | ±100 ±100 | mA |
| P _{tot} | Total power dissipation | | 400 | mW |
| T _A | Operating free-air temperature | - 40 | 85 | °C |
| T _{stg} | Storage temperature | - 65 | 150 | |

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

| | | | VALUE | UNIT |
|---|-------------------------|--|-------|------|
| V _(ESD) Electrostatic discha | | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±2000 | |
| V _(ESD) | Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±1000 | V |

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

See (1)

| | | | MIN | MAX | UNIT |
|----------------------------|--------------------------------|----------------|-----------------------|---|------|
| V _{CC} | Supply voltage | | 2.3 | 5.5 | V |
| V High level innertwelters | | SCL, SDA | 0.7 × V _{CC} | 6 | V |
| V _{IH} | High-level input voltage | A2 - A0, RESET | 0.7 × V _{CC} | V _{CC} + 0.5 | |
| V | Law layel input veltage | SCL, SDA | - 0.5 | 6 V _{CC} + 0.5 0.3 × V _{CC} | V |
| V _{IL} | Low-level input voltage | A2 - A0, RESET | - 0.5 | 0.3 × V _{CC} | · |
| T _A | Operating free-air temperature | | - 40 | 85 | °C |

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, SCBA004.

6.4 Thermal Information

| | | | PCA9546A | | | | | |
|-------------------|--|---------|----------|---------|---------|---------|---------|------|
| | THERMAL METRIC(1) | | DW | PW | RGV | RGY | D | UNIT |
| | | 16 PINS | 16 PINS | 16 PINS | 16 PINS | 16 PINS | 16 PINS | |
| R ₀ JA | Junction-to-ambient thermal resistance | 120 | 57 | 122.3 | 63.2 | 50 | 92.3 | °C/W |

For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

Submit Document Feedback

⁽²⁾ The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| | PARAMETE | ₹ | TEST CO | NDITIONS | V _{CC} | MIN | TYP ⁽¹⁾ | MAX | UNIT |
|-------------------------|--------------------|---|---|---|-----------------|---|--------------------|--|------------|
| V _{PORR} | Power-on reset ve | oltage, V _{CC} rising | No load, | V _I = V _{CC} or GND | | , | 1.2 | 1.5 | V |
| V _{PORF} | Power-on reset ve | oltage, V _{CC} | No load, | V _I = V _{CC} or GND | | 0.8 | 1 | | V |
| | | | | 5 V | | 3.6 | | | |
| V _{PORF} | | | | 4.5 V to 5.5 V | 2.6 | | 4.5 | ı | |
| V | Switch output vol | ane | V _{SWin} = V _{CC} , | I _{SWout} = - 100 | 3.3 V | | 1.9 | | V |
| v pass | Owner output von | age | V SWIN - VCC, | μ А | 3 V to 3.6 V | 0.8 1 3.6 2.6 1.9 1.6 1.5 1.1 3 7 6 10 3 3 3 1.6 1 0.7 1.6 1 0.7 8 8 4.5 4.5 15 6 | 2.8 | | |
| | | | | 2.5 V | | 1.5 | | ı | |
| | | | | | 2.3 V to 2.7 V | 1.1 | | 2 | |
| la | SCL, SDA | | V _{OL} = 0.4 V | | 2.3 V to 5.5 V | 3 | 7 | | mA |
| ·OL | | | V _{OL} = 0.6 V | | 2.0 7 10 0.0 7 | 6 | 10 | | |
| | SCL, SDA | | | | | | | ±1 | ı |
| I. | SC3 - SC0, SD3 | SC3 - SC0, SD3 - SD0 | | | 2.3 V to 5.5 V | | | ±1 | μА |
| 1 | A2 - A0 | | $V_I = V_{CC}$ or GND | | 2.3 V to 3.3 V | | | ±1 | μД. |
| | RESET (4) | | | | | | | ±1 | |
| | Low inputs | | 5.5 V | | 3 | 12 | | | |
| | | ating mode $f_{SCL} = 100 \text{ kHz}$ $V_I = V_{CC} \text{ or GI}$ | $V_I = V_{CC}$ or GND, | $I_0 = 0$ | 3.6 V | | 3 | 11 | |
| | | | | | 2.7 V | | 3 | 10 | ı |
| | | Low inputs $V_I = GND$, $I_O = 0$ | | 5.5 V | | 1.6 | 2 | | |
| I _{CC} | | | V _I = GND, | I _O = 0 | 3.6 V | | 1 | 1.3 | μ Α |
| | | Standby mode | • | 2.7 V | | 0.7 | 1.1 | ı | |
| | Standby mode | | | | 5.5 V | | 1.6 | 2 | ı |
| | | High inputs | $V_I = V_{CC}$ | I _O = 0 | 3.6 V | | 1 | 1.3 | ı |
| | | | | | 2.7 V | | 0.7 | 1.1 | ı |
| | Supply-current | CCL CDA | SCL or SDA input a Other inputs at V _{CC} | | | | 8 | 15 | |
| ∆ I _{CC} | change | SCL, SDA | SCL or SDA input a Other inputs at V _{CC} | | 2.3 V to 5.5 V | | 8 | 15 | μА |
| | A2 - A0 | | V = V = T CND | | 227/4- 5.57/ | | 4.5 | .5 6 | |
| C _i | RESET | | $V_I = V_{CC}$ or GND | | 2.3 V to 5.5 V | | 4.5 | 5.5 | pF |
| 0 (3 | SCL, SDA | SCL, SDA | | Cuitab OFF | 227/4- 557/ | | 15 | 19 | |
| C _{io(OFF)} (3 | SC3 - SC0, SD3 | - SD0 | $V_I = V_{CC}$ or GND, | Switch OFF | 2.3 V to 5.5 V | | 6 | 8 | pF |
| | 1 | | V = 0.4.V | I = 45 : A | 4.5 V to 5.5 V | 4 | 10 | 16 | |
| R _{ON} | Switch on-state re | esistance | $V_{O} = 0.4 V,$ | I _O = 15 mA | 3 V to 3.6 V | 5 | 13 | 20 | Ω |
| | | | V _O = 0.4 V, | I _O = 10 mA | 2.3 V to 2.7 V | 7 | 16 | ±1 ±1 ±1 12 11 10 2 1.3 1.1 15 6 5.5 19 8 | ı |

⁽¹⁾ All typical values are at nominal supply voltage (2.5-V, 3.3-V, or 5-V V_{CC}), $T_A = 25^{\circ}C$.

 ⁽²⁾ The power-on reset circuit resets the I2C bus logic with V_{CC} < V_{PORF}.
 (3) C_{io(ON)} depends on internal capacitance and external capacitance added to the SCn lines when channels(s) are ON.
 (4) RESET = V_{CC} (held high) when all other input voltages, V_I = GND.



6.6 I²C Interface Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see 🗵 7-1)

| | | | MIN | MAX | UNIT |
|------------------------|--|--|------|------|------|
| I ² C BUS— | STANDARD MODE | | | | |
| f _{scl} | I ² C clock frequency | | 0 | 100 | kHz |
| t _{sch} | I ² C clock high time | | 4 | | μs |
| t _{scl} | I ² C clock low time | | 4.7 | | μs |
| t _{sp} | I ² C spike time | | | 50 | ns |
| t _{sds} | I ² C serial-data setup time | | 250 | | ns |
| t _{sdh} | I ² C serial-data hold time | | 0(1) | | ns |
| t _{icr} | I ² C input rise time | | | 1000 | ns |
| t _{icf} | I ² C input fall time | | | 300 | ns |
| t _{ocf} | I ² C output fall time | 10-pF to 400-pF bus | | 300 | ns |
| t _{buf} | I ² C bus free time between stop and start | | 4.7 | | μs |
| t _{sts} | I ² C start or repeated start condition setup | | 4.7 | | μs |
| t _{sth} | I ² C start or repeated start condition hold | | 4 | | μs |
| t _{sps} | I ² C stop condition setup | | 4 | | μs |
| t _{vdL(Data)} | Valid data time (high to low) ⁽²⁾ | SCL low to SDA output low valid | | 1 | μs |
| t _{vdH(Data)} | Valid data time (low to high) ⁽²⁾ | SCL low to SDA output high valid | | 0.6 | μs |
| t _{vd(ack)} | Valid data time of ACK condition | ACK signal from SCL low to SDA (out) low | | 1 | μs |
| C _b | I ² C bus capacitive load | | | 400 | pF |

⁽¹⁾ A device internally must provide a hold time of at least 300 ns for the SDA signal (referred to the V_{IH} min of the SCL signal), in order to bridge the undefined region of the falling edge of SCL.

(2) Data taken using a 1-kΩ pull-up resistor and 50-pF load (see 🗵 7-1)

| | | | MIN | MAX | UNIT |
|------------------------|--|--|---------------------------------------|-----|------|
| I ² C BUS- | -FAST MODE | | | | |
| f _{scl} | I ² C clock frequency | | 0 | 400 | kHz |
| t _{sch} | I ² C clock high time | | 0.6 | | μs |
| t _{scl} | I ² C clock low time | | 1.3 | | μs |
| t _{sp} | ² C spike time | | | 50 | ns |
| t _{sds} | I ² C serial-data setup time | · | | | ns |
| t _{sdh} | I ² C serial-data hold time | | 0(1) | | ns |
| t _{icr} | I ² C input rise time | | 20 + 0.1C _b ⁽²⁾ | 300 | ns |
| t _{icf} | I ² C input fall time | | 20 + 0.1C _b ⁽²⁾ | 300 | ns |
| t _{ocf} | I ² C output fall time | 10-pF to 400-pF bus | 20 + 0.1C _b ⁽²⁾ | 300 | ns |
| t _{buf} | I ² C bus free time between stop and start | | 1.3 | | μs |
| t _{sts} | I ² C start or repeated start condition setup | | 0.6 | | μs |
| t _{sth} | I ² C start or repeated start condition hold | | 0.6 | | μs |
| t _{sps} | I ² C stop condition setup | | 0.6 | | μs |
| t _{vdL(Data)} | Valid data time (high to low) ⁽³⁾ | SCL low to SDA output low valid | | 1 | μs |
| t _{vdH(Data)} | Valid data time (low to high) ⁽³⁾ | SCL low to SDA output high valid | | 0.6 | |
| t _{vd(ack)} | Valid data time of ACK condition | ACK signal from SCL low to SDA (out) low | | 1 | μs |
| C _b | I ² C bus capacitive load | | | 400 | pF |

⁽¹⁾ A device internally must provide a hold time of at least 300 ns for the SDA signal (referred to the V_{IH} min of the SCL signal), in order to bridge the undefined region of the falling edge of SCL.

⁽²⁾ C_b = total bus capacitance of one bus line in pF

⁽³⁾ Data taken using a 1-kΩ pull-up resistor and 50-pF load (see 图 7-1)



6.7 Interrupt and Reset Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted)

| | PARAMETER | MIN | MAX | UNIT |
|-----------------------|-----------------------------------|-----|-----|------|
| t _{WL} | Pulse duration, RESET low | 6 | | ns |
| t _{rst} (1) | RESET time (SDA clear) | | 500 | ns |
| t _{REC(STA)} | Recovery time from RESET to start | 0 | | ns |

⁽¹⁾ t_{rst} is the propagation delay measured from the time the RESET pin is first asserted low to the time the SDA pin is asserted high, signaling a stop condition. It must be a minimum of t_{WL}.

6.8 Switching Characteristics

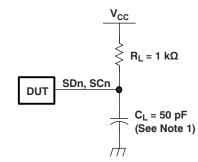
over recommended operating free-air temperature range, $C_L \leqslant 100$ pF (unless otherwise noted) (see \boxtimes 7-1)

| | PARAMETE | R | FROM (INPUT) | TO (OUTPUT) | MIN MA | X UNIT |
|---------|-------------------------|--|-----------------|----------------|--------|----------|
| + . (1) | Propagation delay time | R_{ON} = 20 Ω , C_L = 15 pF | SDA or SCL | SDn or SCn | 0 | .3 ns |
| 'pd ` | 1 Topagation delay time | R_{ON} = 20 Ω , C_L = 50 pF | SDA OF SCE | 3511 01 3611 | | 1 113 |

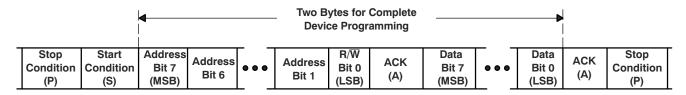
⁽¹⁾ The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).



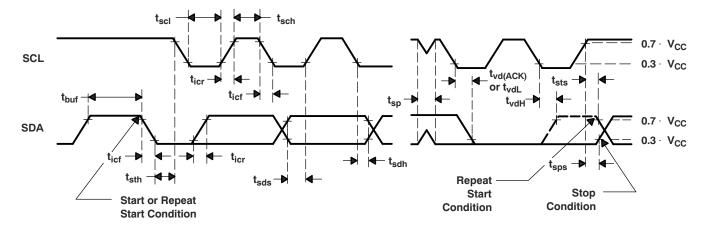
7 Parameter Measurement Information



Copyright © 2016, Texas Instruments Incorporated I²C PORT LOAD CONFIGURATION



| BYTE | DESCRIPTION |
|------|--------------------------------|
| 1 | I ² C address + R/W |
| 2 | Control register data |



VOLTAGE WAVEFORMS

- A. C_L includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR \leqslant 10 MHz, Z_{O} = 50 $\Omega,\,t_{r}/t_{f}\,\leqslant$ 30 ns.
- C. The outputs are measured one at a time, with one transition per measurement.

图 7-1. I²C Interface Load Circuit, Byte Descriptions, and Voltage Waveforms

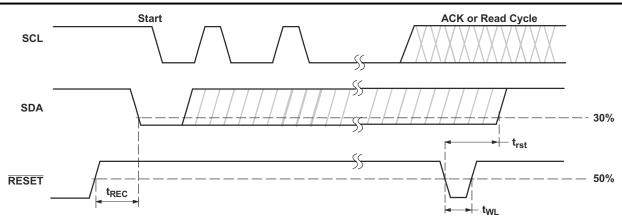


图 7-2. Reset Timing

8 Detailed Description

8.1 Overview

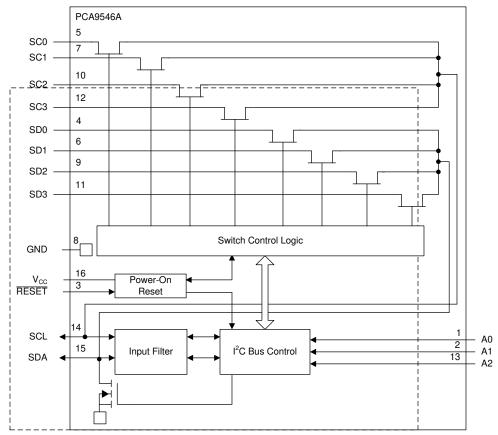
The PCA9546A is a 4-channel, bidirectional translating I²C switch. The master SCL/SDA signal pair is directed to four channels of slave devices, SC0/SD0-SC3/SD3. Any individual downstream channel can be selected as well as any combination of the four channels.

The device offers an active-low \overline{RESET} input which resets the state machine and allows the PCA9546A to recover should one of the downstream I²C buses get stuck in a low state. The state machine of the device can also be reset by cycling the power supply, V_{CC} , also known as a power-on reset (POR). Both the \overline{RESET} function and a POR will cause all channels to be deselected.

The connections of the I²C data path are controlled by the same I²C master device that is switched to communicate with multiple I²C slaves. After the successful acknowledgment of the slave address (hardware selectable by A0 and A1 pins), a single 8-bit control register is written to or read from to determine the selected channels.

The PCA9546A may also be used for voltage translation, allowing the use of different bus voltages on each SCn/SDn pair such that 1.8-V, 2.5-V, or 3.3-V parts can communicate with 5-V parts. This is achieved by using external pull-up resistors to pull the bus up to the desired voltage for the master and each slave channel.

8.2 Functional Block Diagram



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8.3 Feature Description

The PCA9546A is a 4-channel, bidirectional translating switch for I²C buses that supports Standard-Mode (100 kHz) and Fast-Mode (400 kHz) operation. The PCA9546A features I²C control using a single 8-bit control register in which the four least significant bits control the enabling and disabling of the 4 switch channels of I²C data flow. Depending on the application, voltage translation of the I²C bus can also be achieved using the PCA9546A to allow 1.8-V, 2.5-V, or 3.3-V parts to communicate with 5-V parts. Additionally, in the event that communication on the I²C bus enters a fault state, the PCA9546A can be reset to resume normal operation using the RESET pin feature or by a power-on reset which results from cycling power to the device.

8.4 Device Functional Modes

8.4.1 RESET Input

The RESET input is an active-low signal that may be used to recover from a bus-fault condition. When this signal is asserted low for a minimum of t_{WL} , the PCA9546A resets its registers and I^2C state machine and deselects all channels. The RESET input must be connected to V_{CC} through a pull-up resistor.

8.4.1.1 RESET Errata

If RESET voltage set higher than V_{CC} , current will flow from RESET pin to V_{CC} pin.

System Impact

V_{CC} will be pulled above its regular voltage level

System Workaround

Design such that RESET voltage is same or lower than V_{CC}

8.4.2 Power-On Reset

When power is applied to V_{CC} , an internal power-on reset holds the PCA9546A in a reset condition until V_{CC} has reached V_{POR} . At this point, the reset condition is released, and the PCA9546A registers and I^2C state machine are initialized to their default states, all zeroes, causing all the channels to be deselected. Thereafter, V_{CC} must be lowered below V_{POR} to reset the device.

8.5 Programming

8.5.1 I²C Interface

The I²C bus is for two-way two-line communication between different ICs or modules. The two lines are a serial data line (SDA) and a serial clock line (SCL). Both lines must be connected to a positive supply via a pull-up resistor when connected to the output stages of a device. Data transfer can be initiated only when the bus is not busy.

One data bit is transferred during each clock pulse. The data on the SDA line must remain stable during the high period of the clock pulse, as changes in the data line at this time are interpreted as control signals (see 8-1).

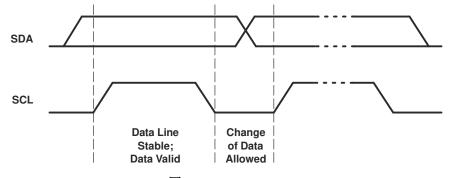


图 8-1. Bit Transfer

Both data and clock lines remain high when the bus is not busy. A high-to-low transition of the data line while the clock is high is defined as the start condition (S). A low-to-high transition of the data line while the clock is high is defined as the stop condition (P) (see 88-2).

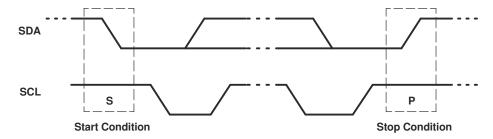


图 8-2. Definition of Start and Stop Conditions

A device generating a message is a transmitter; a device receiving is the receiver. The device that controls the message is the master, and the devices that are controlled by the master are the slaves (see 8-3).

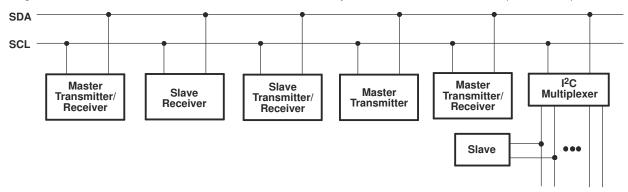


图 8-3. System Configuration

The number of data bytes transferred between the start and the stop conditions from transmitter to receiver is not limited. Each byte of eight bits is followed by one acknowledge (ACK) bit. The transmitter must release the SDA line before the receiver can send an ACK bit.

When a slave receiver is addressed, it must generate an ACK after the reception of each byte. Also, a master must generate an ACK after the reception of each byte that has been clocked out of the slave transmitter. The device that acknowledges must pull down the SDA line during the ACK clock pulse so that the SDA line is stable low during the high pulse of the ACK-related clock period (see 8-4). Setup and hold times must be taken into account.

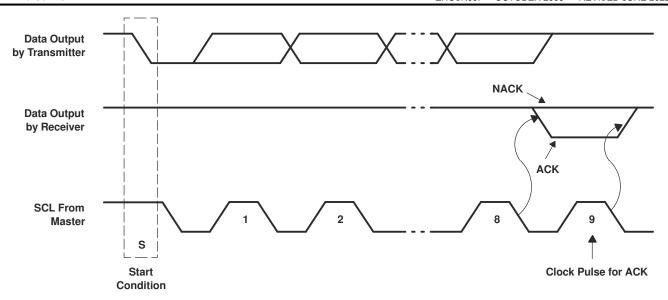


图 8-4. Acknowledgment on the I²C Bus

Data is transmitted to the PCA9546A control register using the write mode shown in 🗵 8-5.

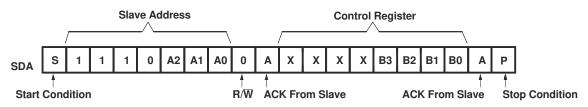


图 8-5. Write Control Register

Data is read from the PCA9546A control register using the read mode shown in 🗵 8-6.

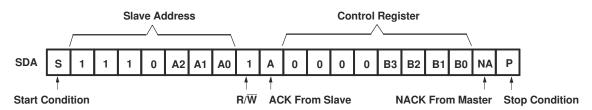


图 8-6. Read Control Register

8.6 Control Register

8.6.1 Device Address

Following a start condition, the bus master must output the address of the slave it is accessing. The address of the PCA9546A is shown in 8-7. To conserve power, no internal pull-up resistors are incorporated on the hardware-selectable address pins, and they must be pulled high or low.

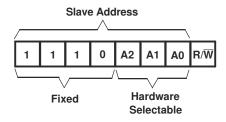


图 8-7. PCA9546A Address

The last bit of the slave address defines the operation to be performed. When set to a logic 1, a read is selected, while a logic 0 selects a write operation.

8.6.2 Control Register Description

Following the successful acknowledgment of the slave address, the bus master sends a byte to the PCA9546A, which is stored in the control register (see 8-8). If multiple bytes are received by the PCA9546A, it will save the last byte received. This register can be written and read via the I²C bus.

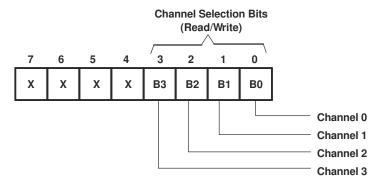


图 8-8. Control Register

8.6.3 Control Register Definition

One or several SCn/SDn downstream pairs, or channels, are selected by the contents of the control register (see $\frac{1}{2}$ 8-1). This register is written after the PCA9546A has been addressed. The four LSBs of the control byte are used to determine which channel or channels are to be selected. When a channel is selected, the channel becomes active after a stop condition has been placed on the I²C bus. This ensures that all SCn/SDn lines are in a high state when the channel is made active, so that no false conditions are generated at the time of connection. A stop condition always must occur right after the acknowledge cycle.

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表 8-1. Control Register Write (Channel Selection), Control Register Read (Channel Status)(1)

| B7 | В6 | B5 | В4 | В3 | B2 | B1 | В0 | COMMAND |
|-----|----|----|----|----|----|----|-----|---|
| Х | Х | Х | Х | Х | Х | Х | 0 | Channel 0 disabled |
| _ ^ | ^ | ^ | ^ | ^ | ^ | ^ | 1 | Channel 0 enabled |
| Х | Х | X | Х | Х | Х | 0 | х | Channel 1 disabled |
| _ ^ | ^ | ^ | ^ | ^ | ^ | 1 | _ ^ | Channel 1 enabled |
| X | Х | X | Х | X | 0 | X | х | Channel 2 disabled |
| _ ^ | ^ | ^ | ^ | ^ | 1 | ^ | ^ | Channel 2 enabled |
| X | Х | Х | Х | 0 | Х | Х | х | Channel 3 disabled |
| _ ^ | ^ | ^ | ^ | 1 | ^ | ^ | ^ | Channel 3 enabled |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | No channel selected, power-up/reset default state |

⁽¹⁾ Several channels can be enabled at the same time. For example, B3 = 0, B2 = 1, B1 = 1, B0 = 0 means that channels 0 and 3 are disabled, and channels 1 and 2 are enabled. Care must be taken not to exceed the maximum bus capacity.

9 Application Information Disclaimer

备注

以下应用部分中的信息不属于 TI 器件规格的范围, TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计,以确保系统功能。

9.1 Application Information

Applications of the PCA9546A will contain an I^2C (or SMBus) master device and up to four I^2C slave devices. The downstream channels are ideally used to resolve I^2C slave address conflicts. For example, if four identical digital temperature sensors are needed in the application, one sensor can be connected at each channel: 0, 1, 2, and 3. When the temperature at a specific location must be read, the appropriate channel can be enabled and all other channels switched off, the data can be retrieved, and the I^2C master can move on and read the next channel.

In an application where the I²C bus will contain many additional slave devices that do not result in I²C slave address conflicts, these slave devices can be connected to any desired channel to distribute the total bus capacitance across multiple channels. If multiple switches will be enabled simultaneously, additional design requirements must be considered (See *Design Requirements* and *Detailed Design Procedure*).

9.2 Typical Application

A typical application of the PCA9546A will contain anywhere from 1 to 5 separate data pull-up voltages, V_{DPUX} , one for the master device (V_{DPUM}) and one for each of the selectable slave channels ($V_{DPU0} - V_{DPU3}$). In the event where the master device and all slave devices operate at the same voltage, then the pass voltage, $V_{pass} = V_{DPUX}$. Once the maximum V_{pass} is known, V_{CC} can be selected easily using 9-2. In an application where voltage translation is necessary, additional design requirements must be considered (See *Design Requirements*).

⊗ 9-1 shows an application in which the PCA9546A can be used.

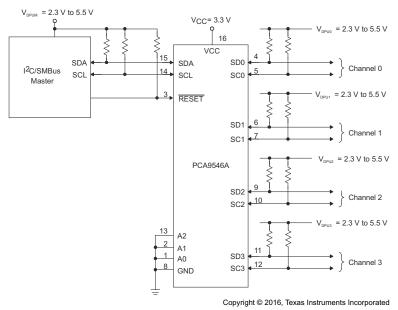


图 9-1. PCA9546A Typical Application Schematic

9.2.1 Design Requirements

The A0, A1, and A2 pins are hardware selectable to control the slave address of the PCA9546A. These pins may be tied directly to GND or V_{CC} in the application.

If multiple slave channels will be activated simultaneously in the application, then the total I_{OL} from SCL/SDA to GND on the master side will be the sum of the currents through all pull-up resistors, R_p .

The pass-gate transistors of the PCA9546A are constructed such that the V_{CC} voltage can be used to limit the maximum voltage that is passed from one I^2C bus to another.

Solution 9-2 shows the voltage characteristics of the pass-gate transistors (note that the graph was generated using data specified in the *Electrical Characteristics* section of this data sheet). In order for the PCA9546A to act as a voltage translator, the V_{pass} voltage must be equal to or lower than the lowest bus voltage. For example, if the main bus is running at 5 V and the downstream buses are 3.3 V and 2.7 V, V_{pass} must be equal to or below 2.7 V to effectively clamp the downstream bus voltages. As shown in Solution 9-2, V_{pass(max)} is 2.7 V when the PCA9546A supply voltage is 4 V or lower, so the PCA9546A supply voltage could be set to 3.3 V. Pull-up resistors then can be used to bring the bus voltages to their appropriate levels (see Solution 9-1).

9.2.2 Detailed Design Procedure

Once all the slaves are assigned to the appropriate slave channels and bus voltages are identified, the pull-up resistors, R_p , for each of the buses need to be selected appropriately. The minimum pull-up resistance is a function of V_{DPUX} , $V_{OL,(max)}$, and I_{OL} as shown in $\bar{\jmath}$ $\bar{\jmath}$ 1:

$$R_{p(min)} = \frac{V_{DPUX} - V_{OL(max)}}{I_{OL}}$$
(1)

The maximum pull-up resistance is a function of the maximum rise time, t_r (300 ns for fast-mode operation, f_{SCL} = 400 kHz) and bus capacitance, C_b as shown in 方程式 2:

$$R_{p(max)} = \frac{t_r}{0.8473 \times C_b} \tag{2}$$

The maximum bus capacitance for an I^2C bus must not exceed 400 pF for fast-mode operation. The bus capacitance can be approximated by adding the capacitance of the PCA9546A, $C_{io(OFF)}$, the capacitance of wires/connections/traces, and the capacitance of each individual slave on a given channel. If multiple channels will be activated simultaneously, each of the slaves on all channels will contribute to total bus capacitance.

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9.2.3 Application Curves

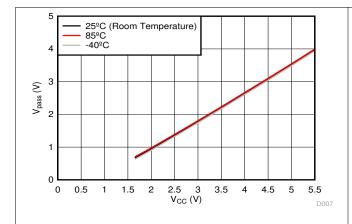


图 9-2. Pass-Gate Voltage (V_{pass}) vs Supply Voltage (V_{CC}) at Three Temperature Points

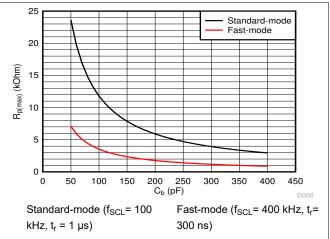


图 9-3. Maximum Pull-Up resistance $(R_{p(max)})$ vs Bus Capacitance (C_b)

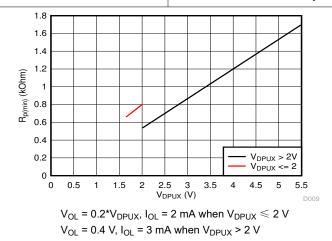


图 9-4. Minimum Pull-Up Resistance (R_{p(min)}) vs Pull-Up Reference Voltage (V_{DPUX})

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10 Power Supply Recommendations

10.1 Power-On Reset Requirements

In the event of a glitch or data corruption, PCA9546A can be reset to its default conditions by using the power-on reset feature. Power-on reset requires that the device go through a power cycle to be completely reset. This reset also happens when the device is powered on for the first time in an application.

The two types of power-on reset are shown in 图 10-1 and 图 10-2.

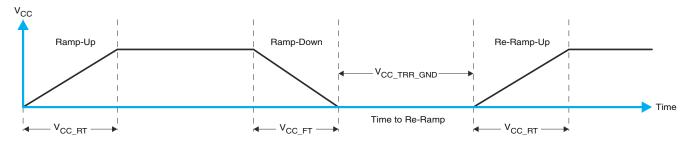


图 10-1. V_{CC} Is Lowered Below 0.2 V Or 0 V And Then Ramped Up To V_{CC}

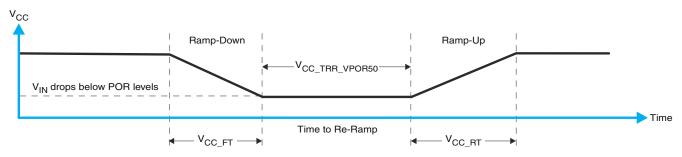


图 10-2. V_{CC} is Lowered Below The Por Threshold, Then Ramped Back Up To V_{CC}

表 10-1 specifies the performance of the power-on reset feature for PCA9546A for both types of power-on reset.

表 10-1. Recommended Supply Sequencing And Ramp Rates⁽¹⁾

| | PARAMETER | | MIN | TYP MAX | UNIT |
|---------------------------|--|------------|-------|---------|------|
| V _{CC_FT} | Fall rate | See 图 10-1 | 1 | 100 | ms |
| V _{CC_RT} | Rise rate | See 图 10-1 | 0.01 | 100 | ms |
| V _{CC_TRR_GND} | Time to re-ramp (when V _{CC} drops to GND) | See 图 10-1 | 0.001 | | ms |
| V _{CC_TRR_POR50} | Time to re-ramp (when V _{CC} drops to V _{POR_MIN} - 50 mV) | See 图 10-2 | 0.001 | | ms |
| V _{CC_GH} | Level that V_{CCP} can glitch down to, but not cause a functional disruption when V_{CCX_GW} = 1 $~\mu$ s | See 图 10-3 | | 1.2 | V |
| V _{CC_GW} | Glitch width that will not cause a functional disruption when $V_{CCX_GH} = 0.5 \times V_{CCx}$ | See 图 10-3 | | | μs |
| V _{PORF} | Voltage trip point of POR on falling V _{CC} | | 0.767 | 1.144 | V |
| V _{PORR} | Voltage trip point of POR on rising V _{CC} | | 1.033 | 1.428 | V |

(1) $T_A = -40$ °C to 85°C (unless otherwise noted)

Glitches in the power supply can also affect the power-on reset performance of this device. The glitch width (V_{CC_GW}) and height (V_{CC_GH}) are dependent on each other. The bypass capacitance, source impedance, and the device impedance are factors that affect power-on reset performance. \boxtimes 10-3 and \gtrless 10-1 provide more information on how to measure these specifications.

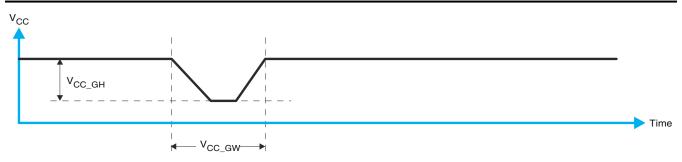
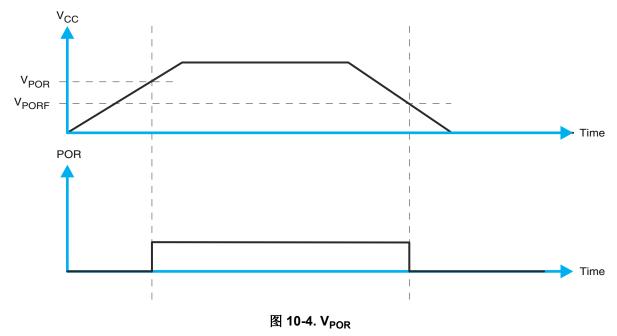


图 10-3. Glitch Width And Glitch Height

 V_{POR} is critical to the power-on reset. V_{POR} is the voltage level at which the reset condition is released and all the registers and the I²C/SMBus state machine are initialized to their default states. The value of V_{POR} differs based on the V_{CC} being lowered to or from 0. \boxtimes 10-4 and \gtrapprox 10-1 provide more details on this specification.



11 Layout

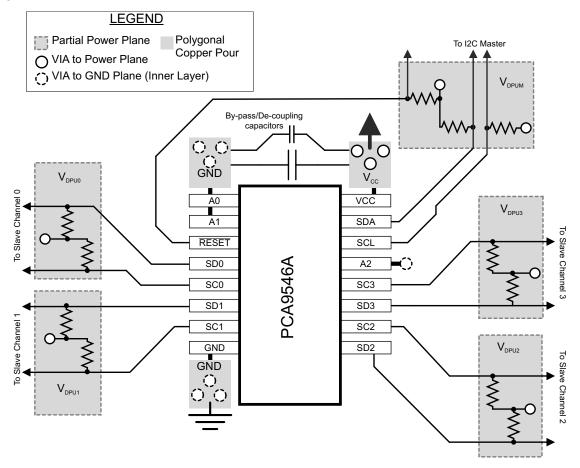
11.1 Layout Guidelines

For PCB layout of the PCA9546A, common PCB layout practices must be followed but additional concerns related to high-speed data transfer such as matched impedances and differential pairs are not a concern for I^2C signal speeds. It is common to have a dedicated ground plane on an inner layer of the board and pins that are connected to ground must have a low-impedance path to the ground plane in the form of wide polygon pours and multiple vias. By-pass and de-coupling capacitors are commonly used to control the voltage on the V_{CC} pin, using a larger capacitor to provide additional power in the event of a short power supply glitch and a smaller capacitor to filter out high-frequency ripple.

In an application where voltage translation is not required, all V_{DPUX} voltages and V_{CC} could be at the same potential and a single copper plane could connect all of pull-up resistors to the appropriate reference voltage. In an application where voltage translation is required, V_{DPUM} , V_{DPU0} , V_{DPU1} , V_{DPU2} , and V_{DPU3} may all be on the same layer of the board with split planes to isolate different voltage potentials.

To reduce the total I²C bus capacitance added by PCB parasitics, data lines (SCn and SDn) must be a short as possible and the widths of the traces must also be minimized (e.g. 5-10 mils depending on copper weight).

11.2 Layout Example





12 Device and Documentation Support

12.1 接收文档更新通知

要接收文档更新通知,请导航至 ti.com 上的器件产品文件夹。点击*订阅更新* 进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

12.2 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料,可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者"按原样"提供。这些内容并不构成 TI 技术规范,并且不一定反映 TI 的观点;请参阅 TI 的《使用条款》。

12.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 术语表

TI术语表本术语表列出并解释了术语、首字母缩略词和定义。

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation

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PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------|--------------|--------------------|------|----------------|--------------|-------------------------------|---------------------|--------------|----------------------|---------|
| | (., | | Ū | | | (-) | (6) | (5) | | () | |
| PCA9546ADGVR | LIFEBUY | TVSOP | DGV | 16 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | PD546A | |
| PCA9546ADR | ACTIVE | SOIC | D | 16 | 2500 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | PCA9546A | Samples |
| PCA9546ADW | LIFEBUY | SOIC | DW | 16 | 40 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | PCA9546A | |
| PCA9546ADWR | LIFEBUY | SOIC | DW | 16 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | PCA9546A | |
| PCA9546APWR | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | PD546A | Samples |
| PCA9546APWRE4 | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | PD546A | Samples |
| PCA9546APWRG4 | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | PD546A | Samples |
| PCA9546ARGVR | ACTIVE | VQFN | RGV | 16 | 2500 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | PD546A | Samples |
| PCA9546ARGYR | NRND | VQFN | RGY | 16 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | PD546A | |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- ⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

www.ti.com 31-May-2023

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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www.ti.com 22-Feb-2023

TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width |
|----|---|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

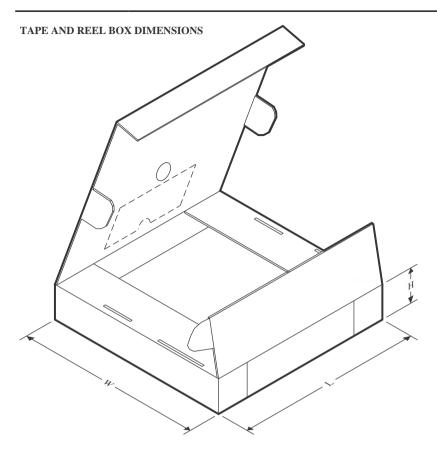


*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| PCA9546ADGVR | TVSOP | DGV | 16 | 2000 | 330.0 | 12.4 | 6.8 | 4.0 | 1.6 | 8.0 | 12.0 | Q1 |
| PCA9546ADR | SOIC | D | 16 | 2500 | 330.0 | 16.4 | 6.5 | 10.3 | 2.1 | 8.0 | 16.0 | Q1 |
| PCA9546ADWR | SOIC | DW | 16 | 2000 | 330.0 | 16.4 | 10.75 | 10.7 | 2.7 | 12.0 | 16.0 | Q1 |
| PCA9546APWR | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| PCA9546APWR | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| PCA9546ARGVR | VQFN | RGV | 16 | 2500 | 330.0 | 12.4 | 4.25 | 4.25 | 1.15 | 8.0 | 12.0 | Q2 |
| PCA9546ARGYR | VQFN | RGY | 16 | 3000 | 330.0 | 12.4 | 3.8 | 4.3 | 1.5 | 8.0 | 12.0 | Q1 |



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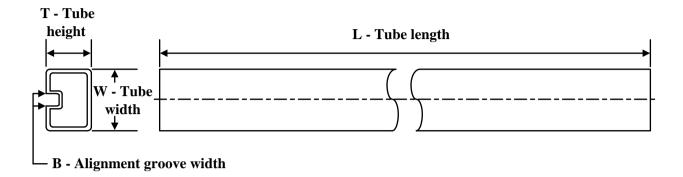
*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| PCA9546ADGVR | TVSOP | DGV | 16 | 2000 | 356.0 | 356.0 | 35.0 |
| PCA9546ADR | SOIC | D | 16 | 2500 | 356.0 | 356.0 | 35.0 |
| PCA9546ADWR | SOIC | DW | 16 | 2000 | 350.0 | 350.0 | 43.0 |
| PCA9546APWR | TSSOP | PW | 16 | 2000 | 356.0 | 356.0 | 35.0 |
| PCA9546APWR | TSSOP | PW | 16 | 2000 | 367.0 | 367.0 | 35.0 |
| PCA9546ARGVR | VQFN | RGV | 16 | 2500 | 367.0 | 367.0 | 35.0 |
| PCA9546ARGYR | VQFN | RGY | 16 | 3000 | 356.0 | 356.0 | 35.0 |

PACKAGE MATERIALS INFORMATION

www.ti.com 22-Feb-2023

TUBE



*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| PCA9546ADW | DW | SOIC | 16 | 40 | 506.98 | 12.7 | 4826 | 6.6 |

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.





SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

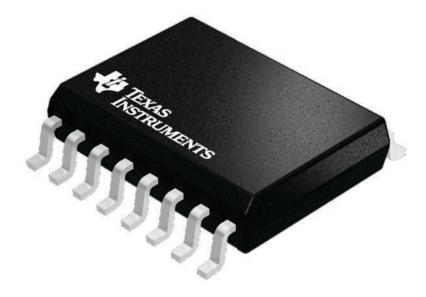
- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



7.5 x 10.3, 1.27 mm pitch

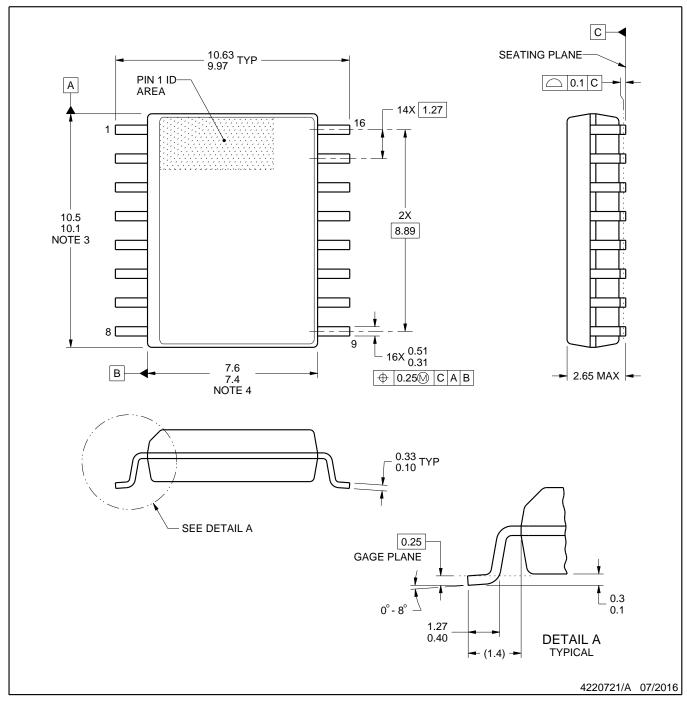
SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



NOTES:

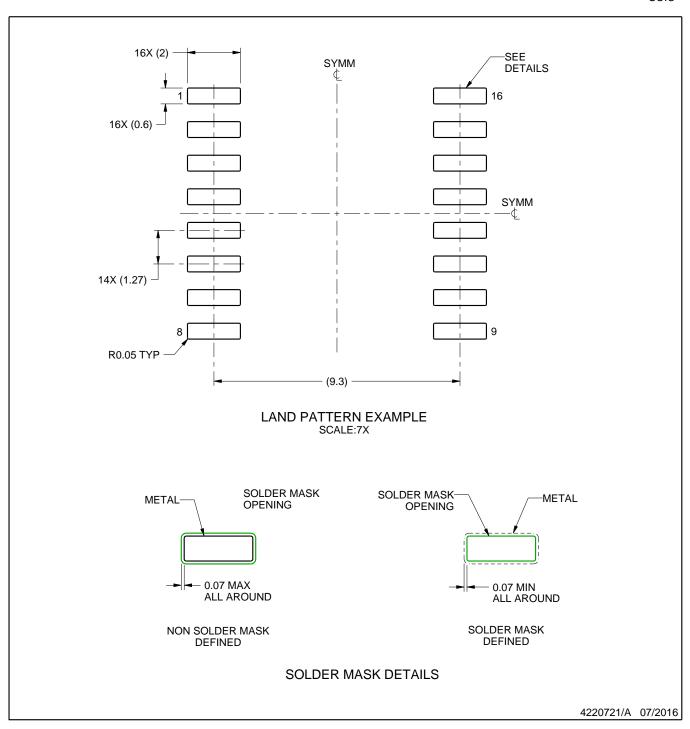
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



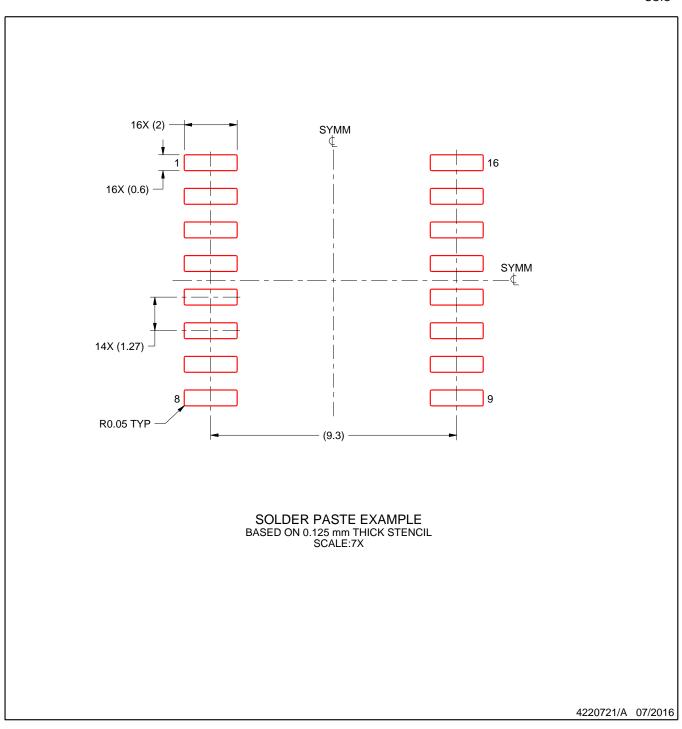
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



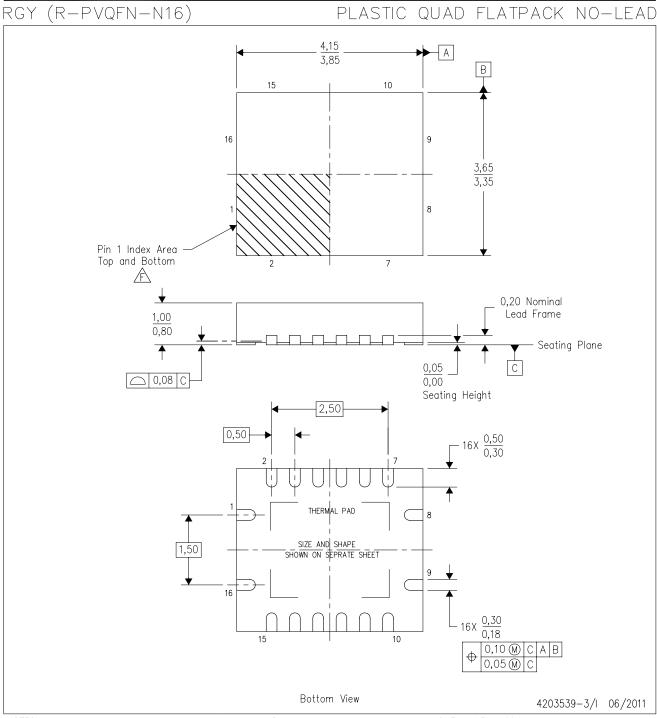
SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (R-PVQFN-N16)

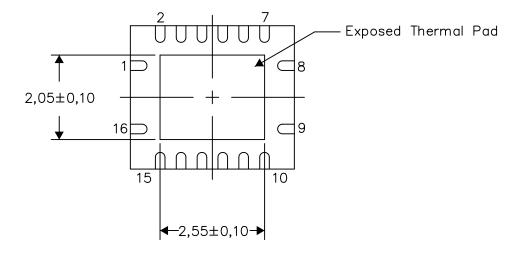
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

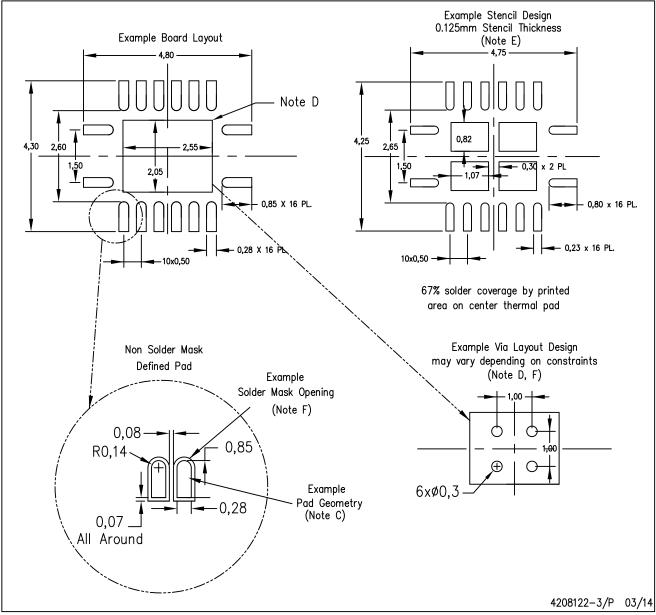
4206353-3/P 03/14

NOTE: All linear dimensions are in millimeters



RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



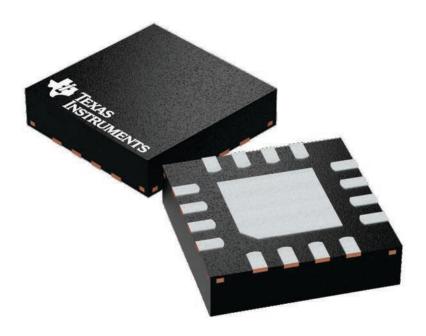
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



4 x 4, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD



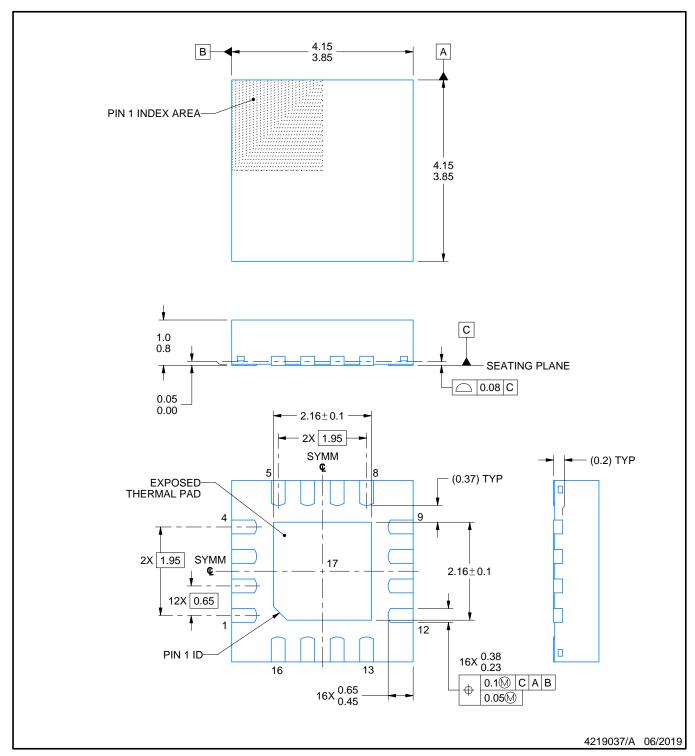
Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4224748/A





PLASTIC QUAD FLATPACK - NO LEAD

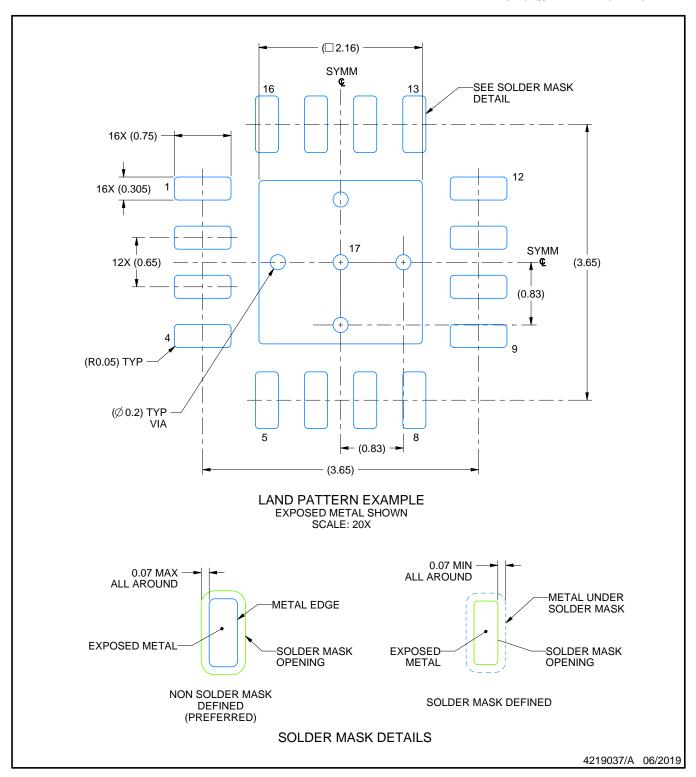


NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD

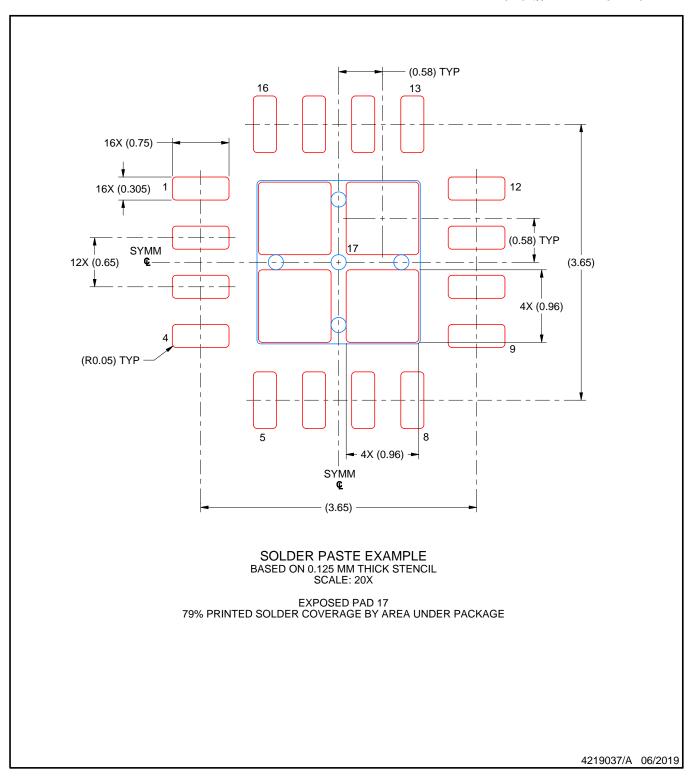


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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